



<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10762972</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>CHEN ET AL.</p>
	<p>Examiner</p> <p>Idowu, Olugbenga O</p>	<p>Art Unit</p> <p>2621</p>


Class	SubClass	Date	Examiner
725	31,63,105	10/17/06	O. I.
725	26,82,116,138,151,146	10/26/06	O.I.

U.S. Patent and Trademark Office	Part of Paper No.: 20061016
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<b><i>Interference Searched</i></b>  	Application/Control No.  10762972	Applicant(s)/Patent Under Reexamination  CHEN ET AL.
	Examiner Idowu, Olugbenga O	Art Unit 2621

<b>Class</b>	<b>SubClass</b>	<b>Date</b>	<b>Examiner</b>
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<b>Search Notes</b>  	Application/Control No.  10762972	Applicant(s)/Patent Under Reexamination  CHEN ET AL.
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<b>Notes</b>	<b>Date</b>	<b>Examiner</b>
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